

<b>Notice of References Cited</b>	Application/Control No. 10/507,321	Applicant(s)/Patent Under Reexamination FUJII ET AL.	
	Examiner ELIAS ULLAH	Art Unit 2892	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0115235	08-2002	Sawada, Hiroshi	438/113
*	B	US-2003/0010275	01-2003	Radojevic et al.	117/2
*	C	US-4,899,126	02-1990	Yamada, Takeharu	338/309
*	D	US-6,376,797	04-2002	Piwczyk et al.	219/121.72
*	E	US-6,420,678	07-2002	Hoekstra, Brian L.	219/121.75
*	F	US-2001/0035401	11-2001	Manor, Ran	219/121.72
*	G	US-2003/0141570	07-2003	Chen et al.	257/618
*	H	US-6,726,631	04-2004	Hatangadi et al.	600/459
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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